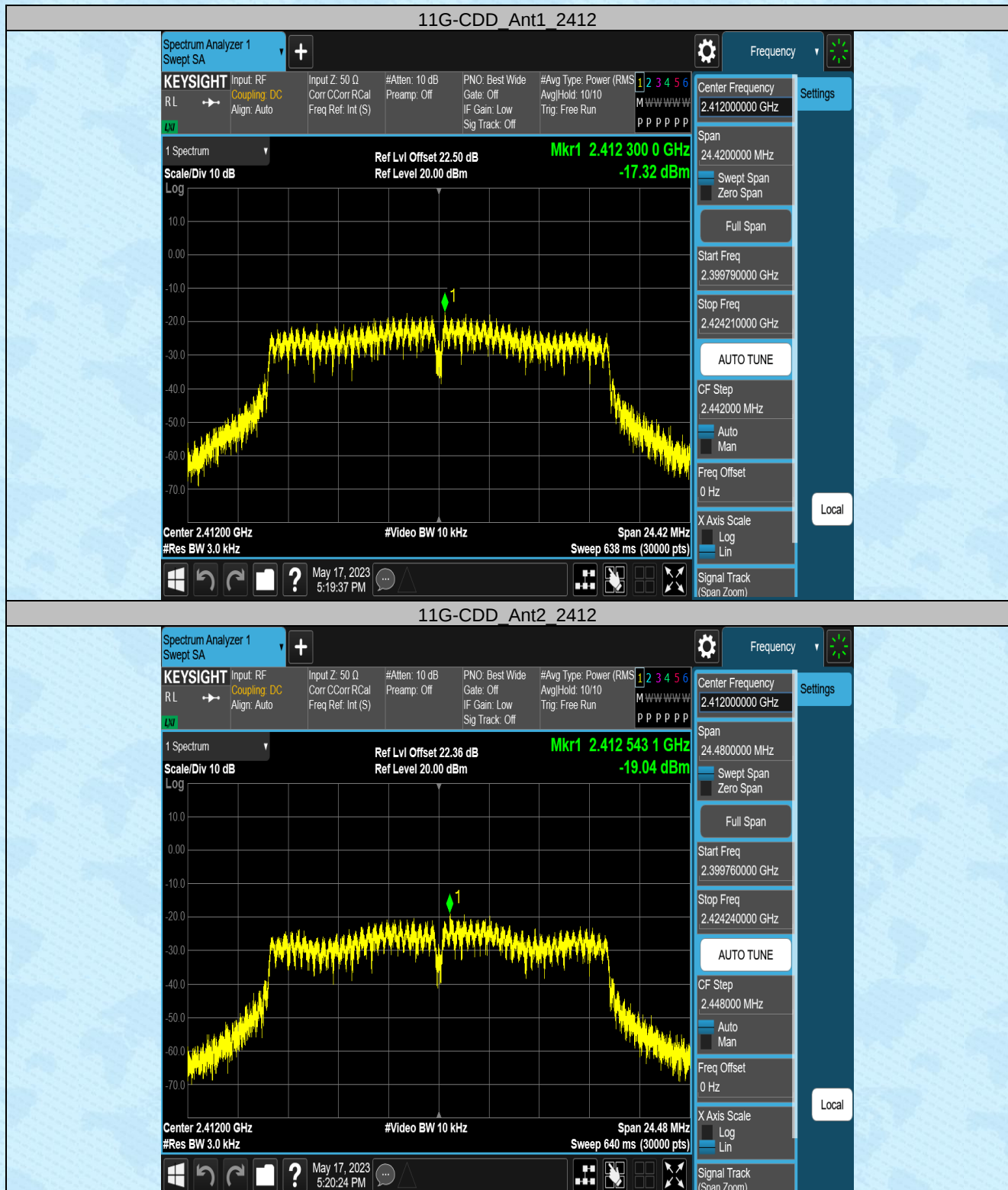
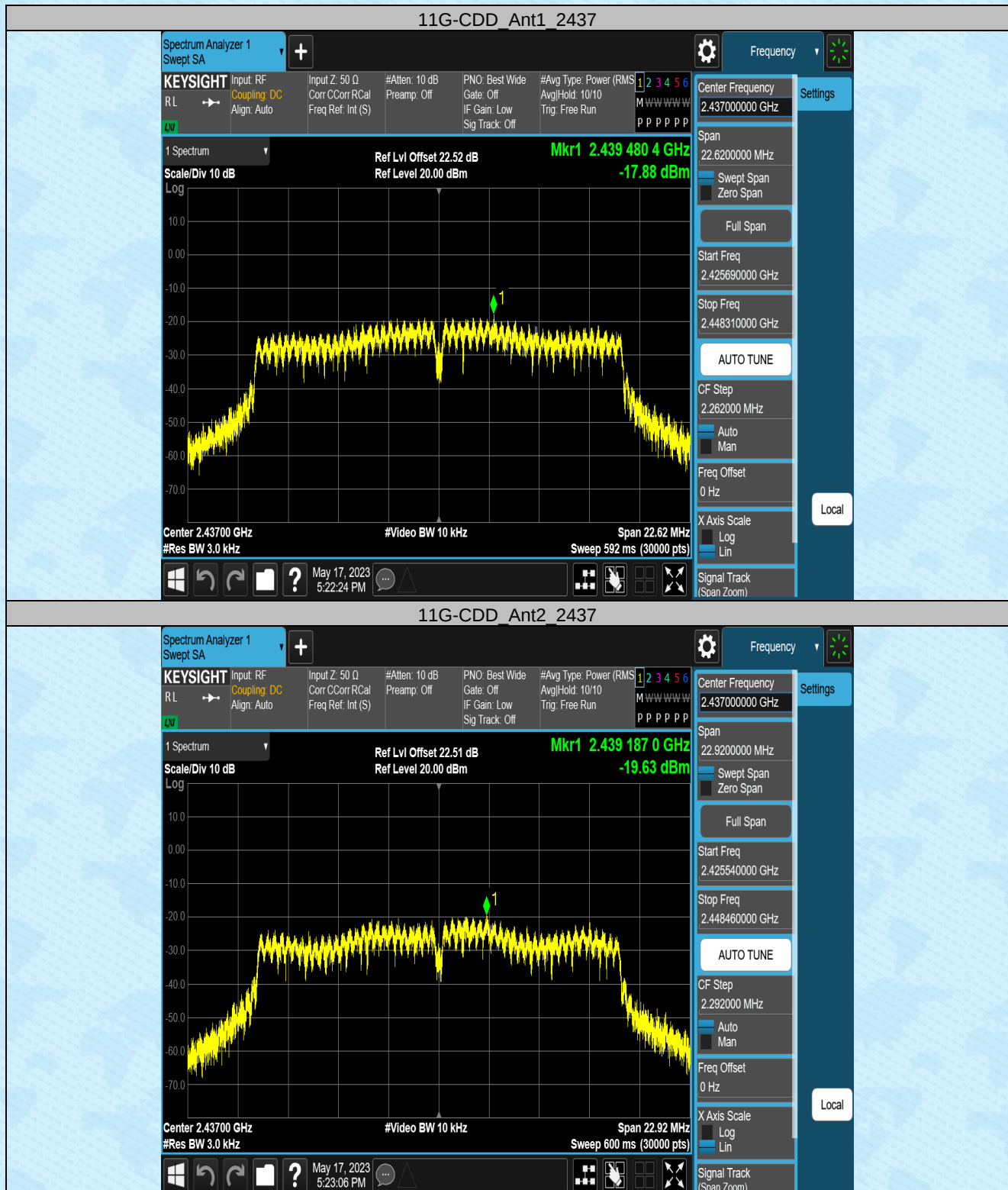
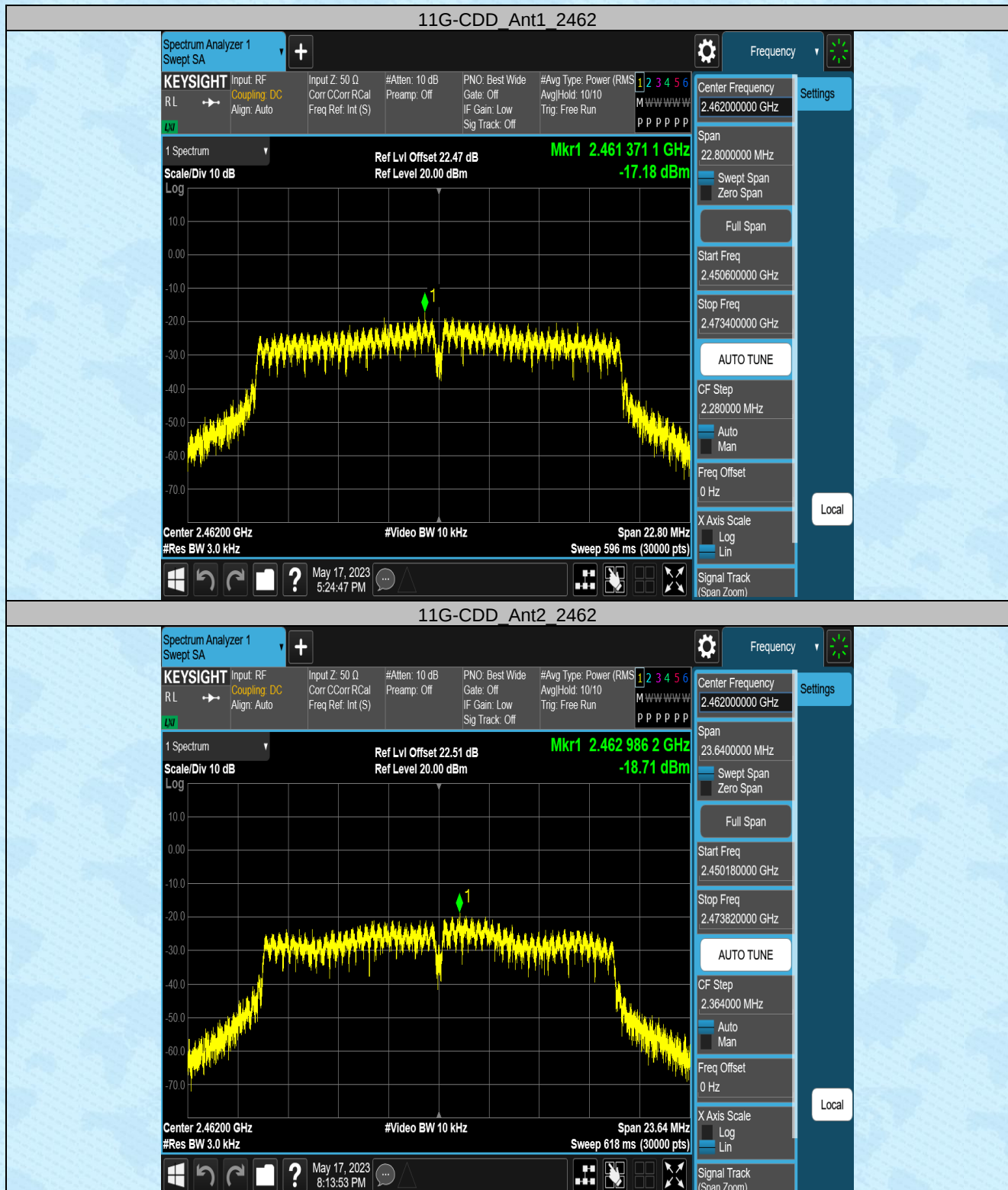


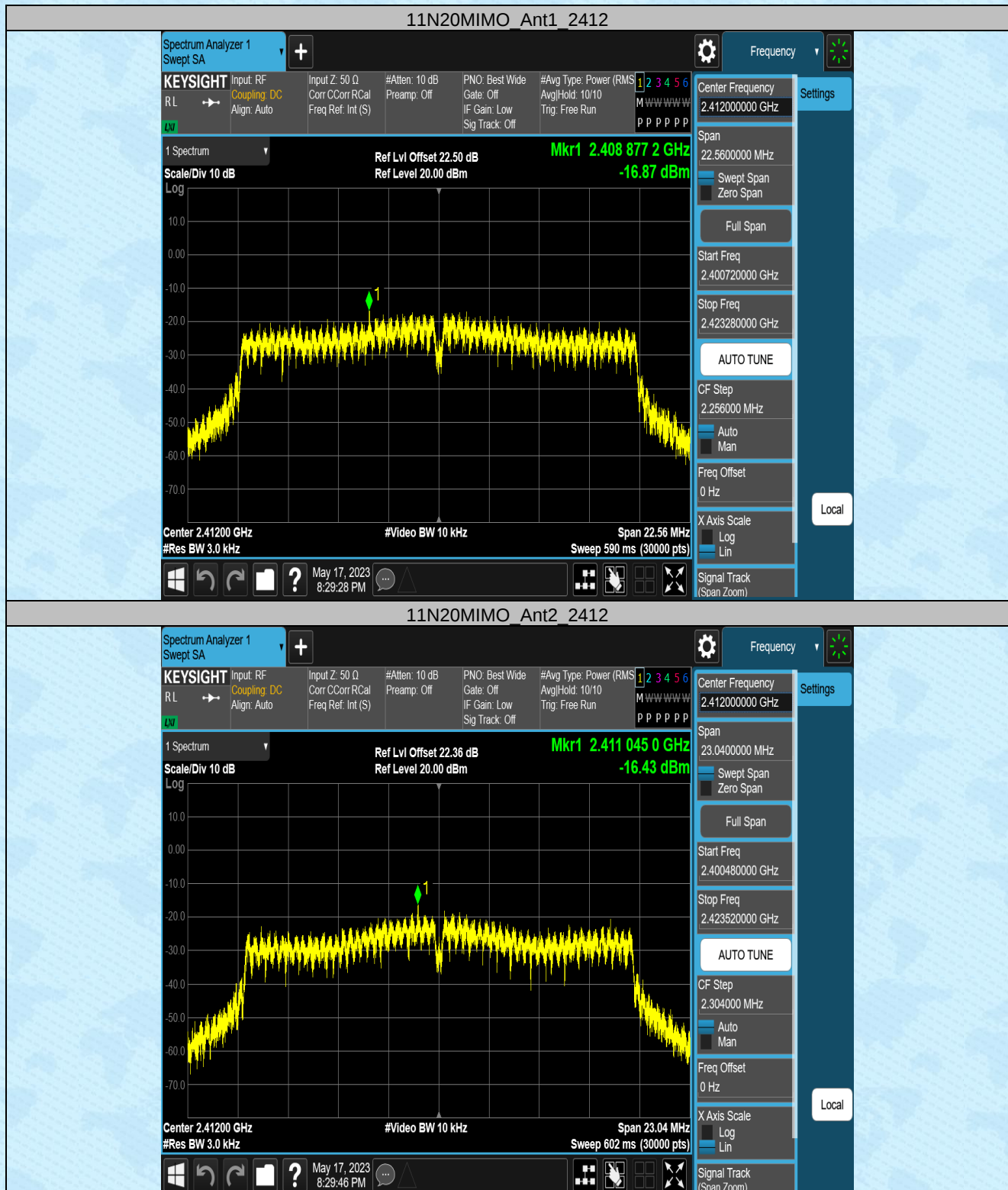






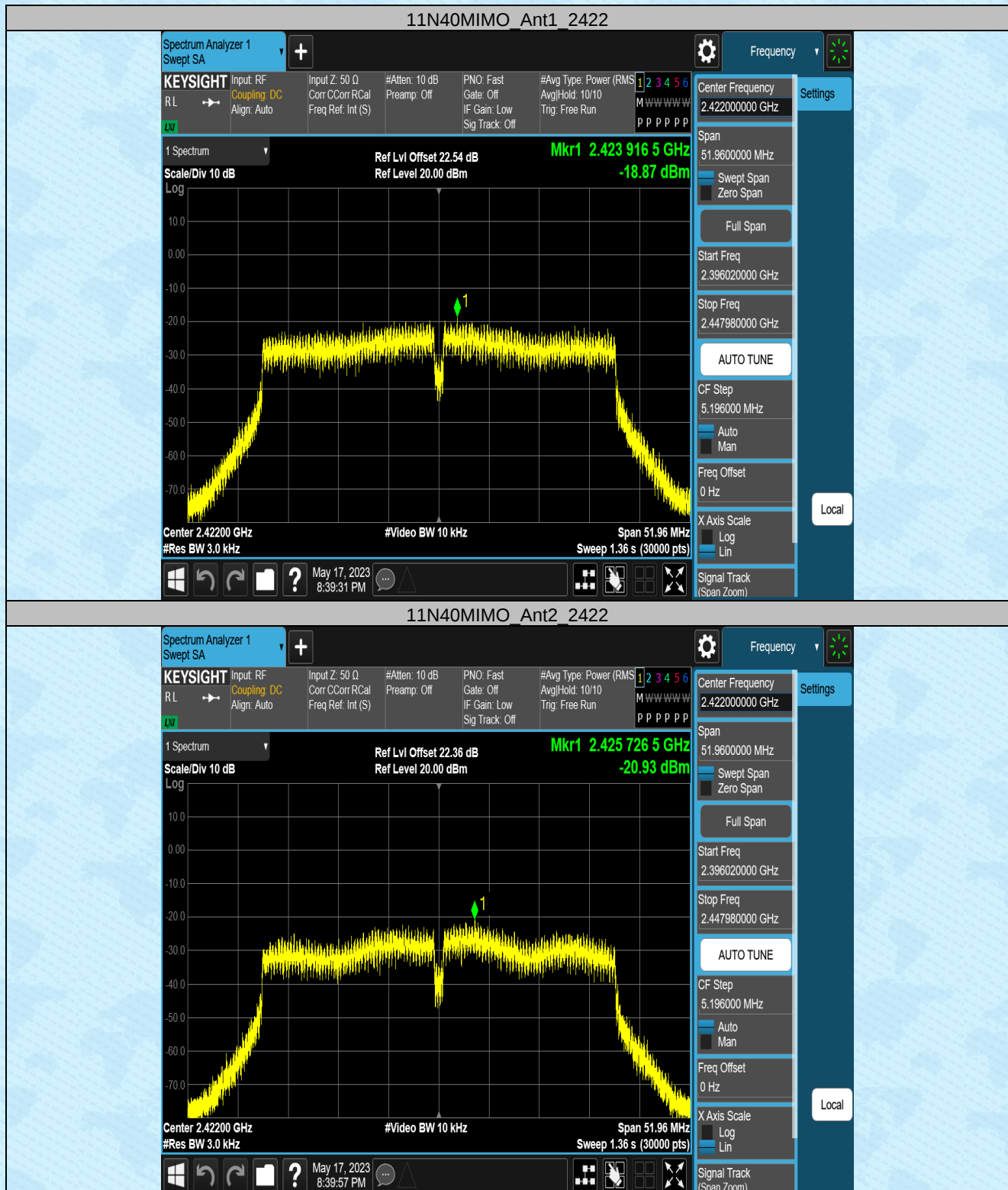


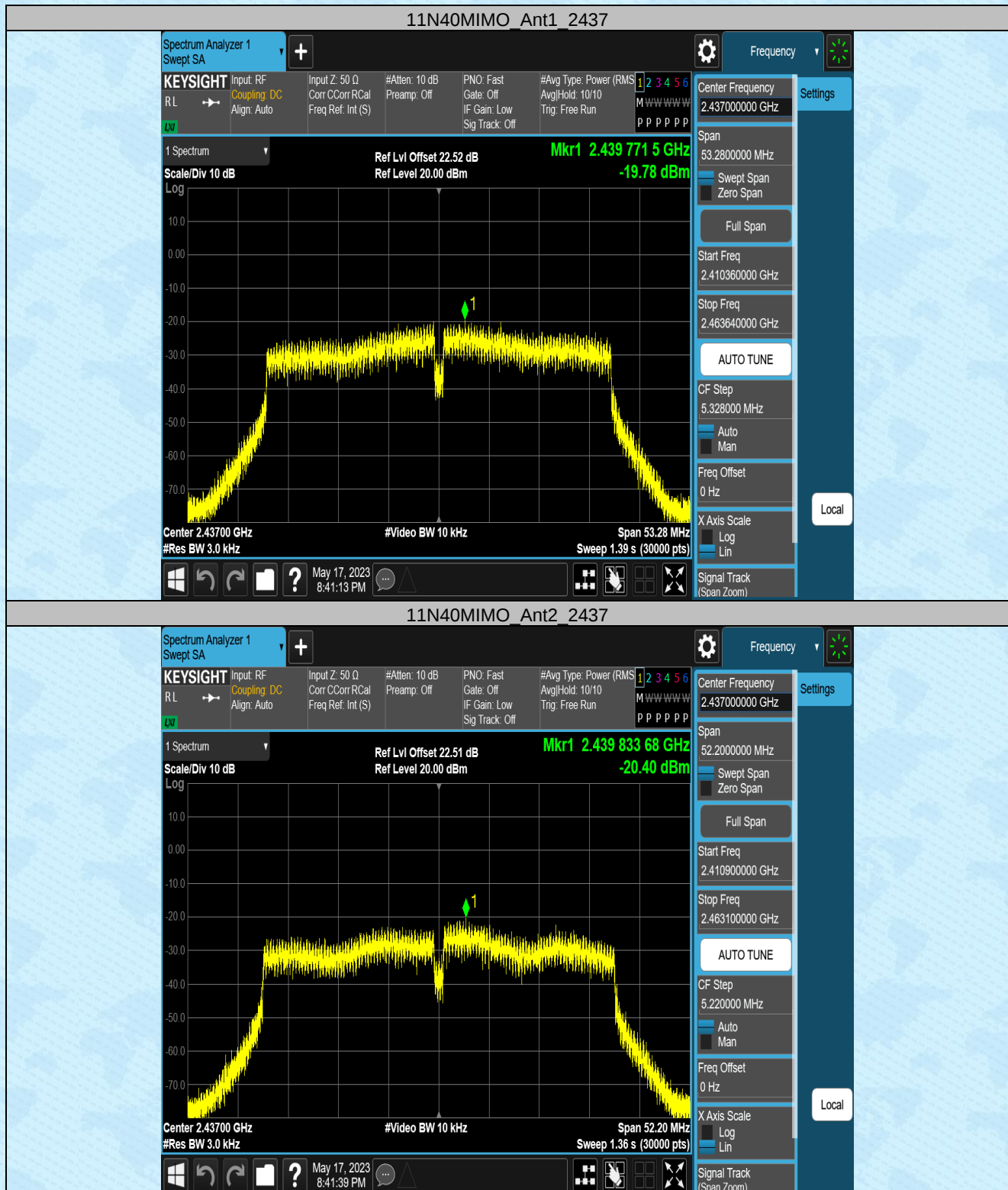


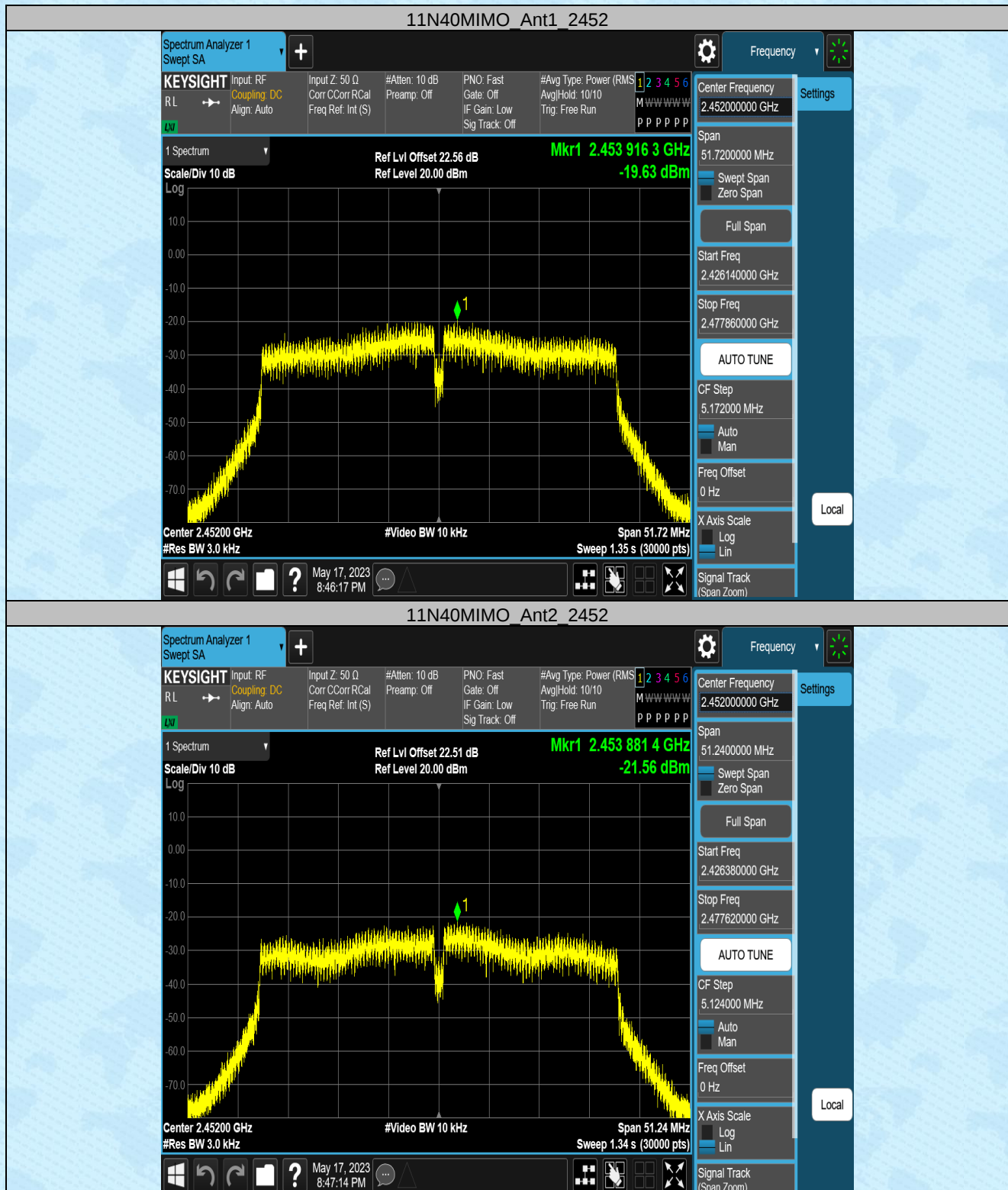


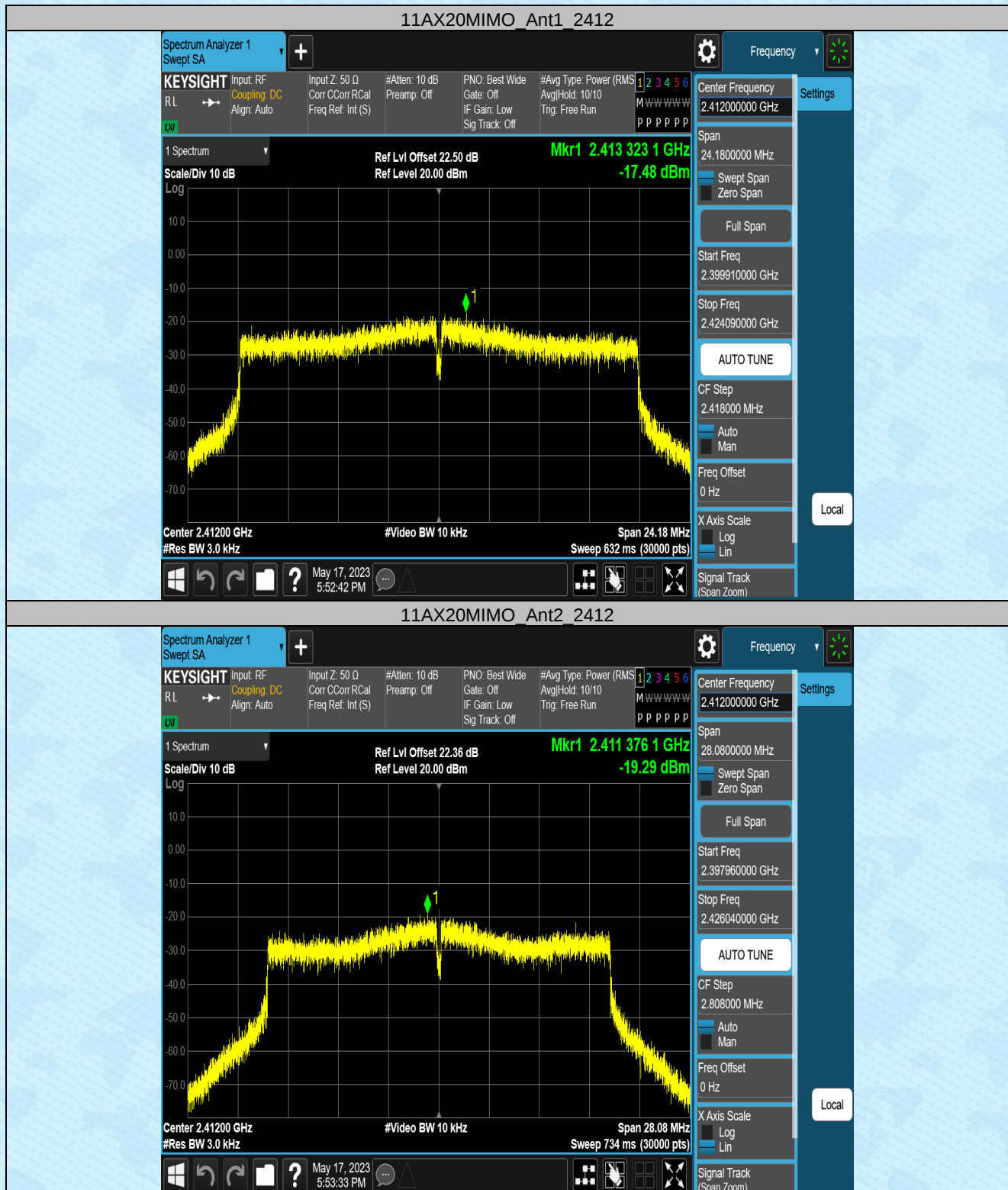


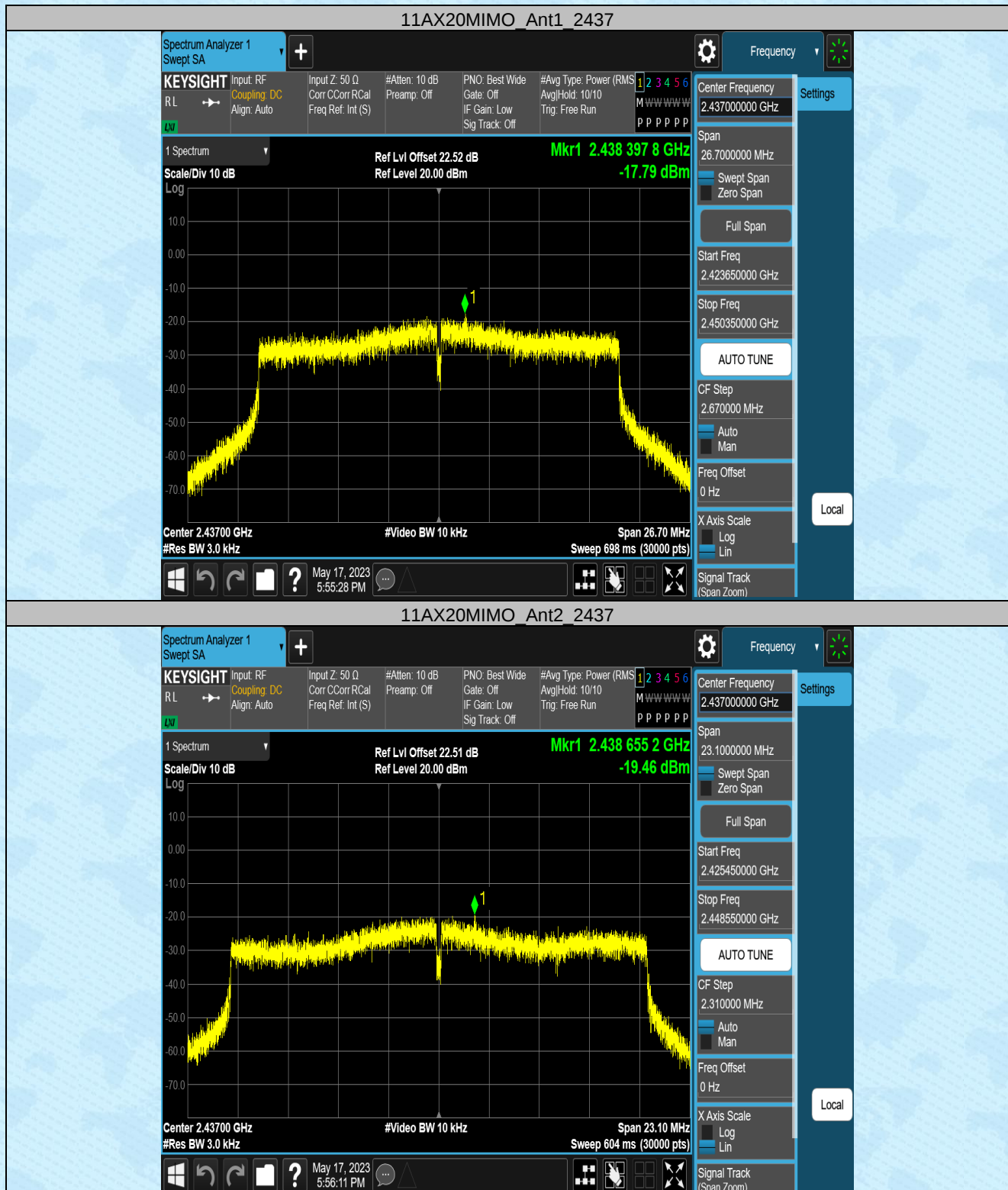


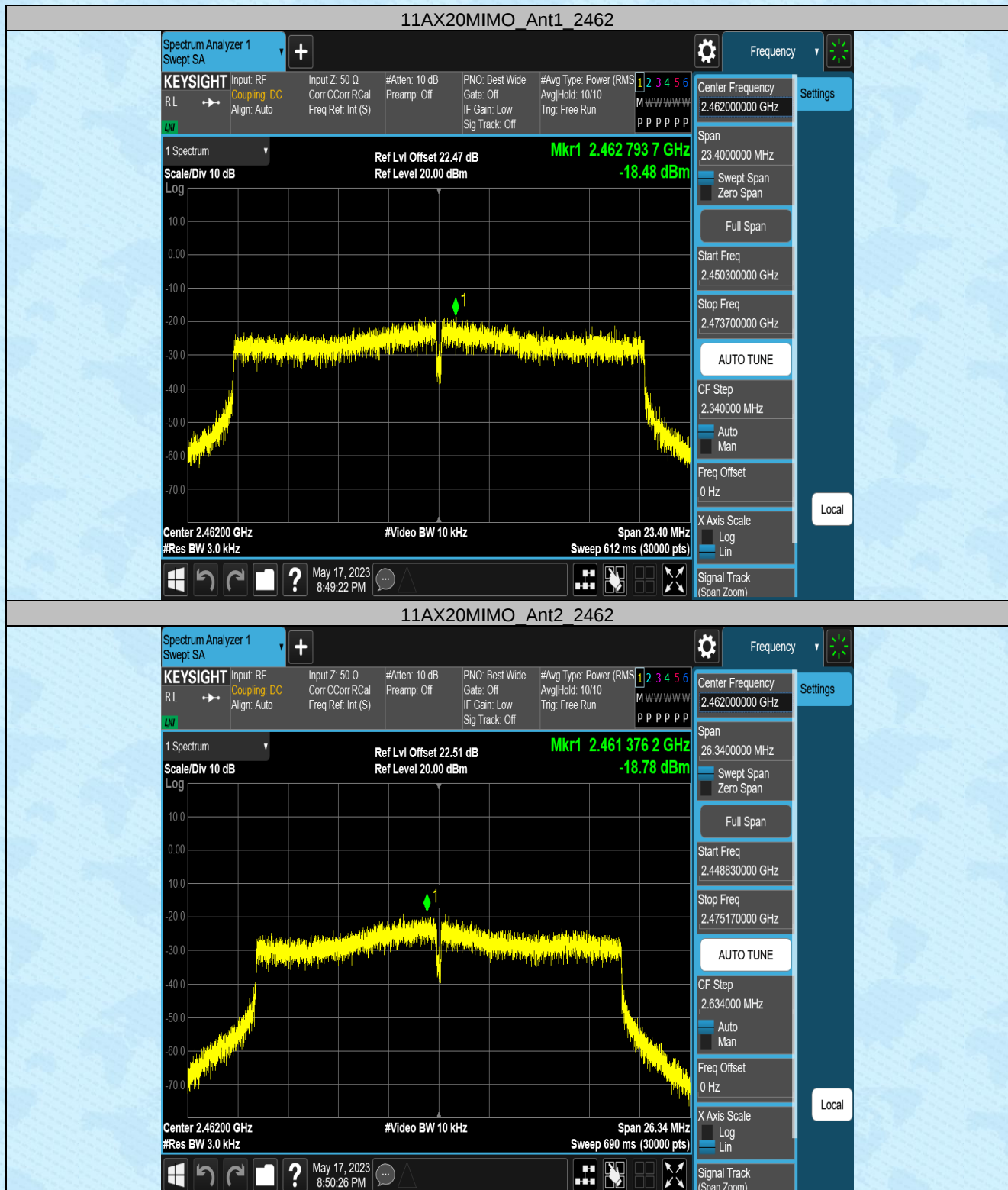


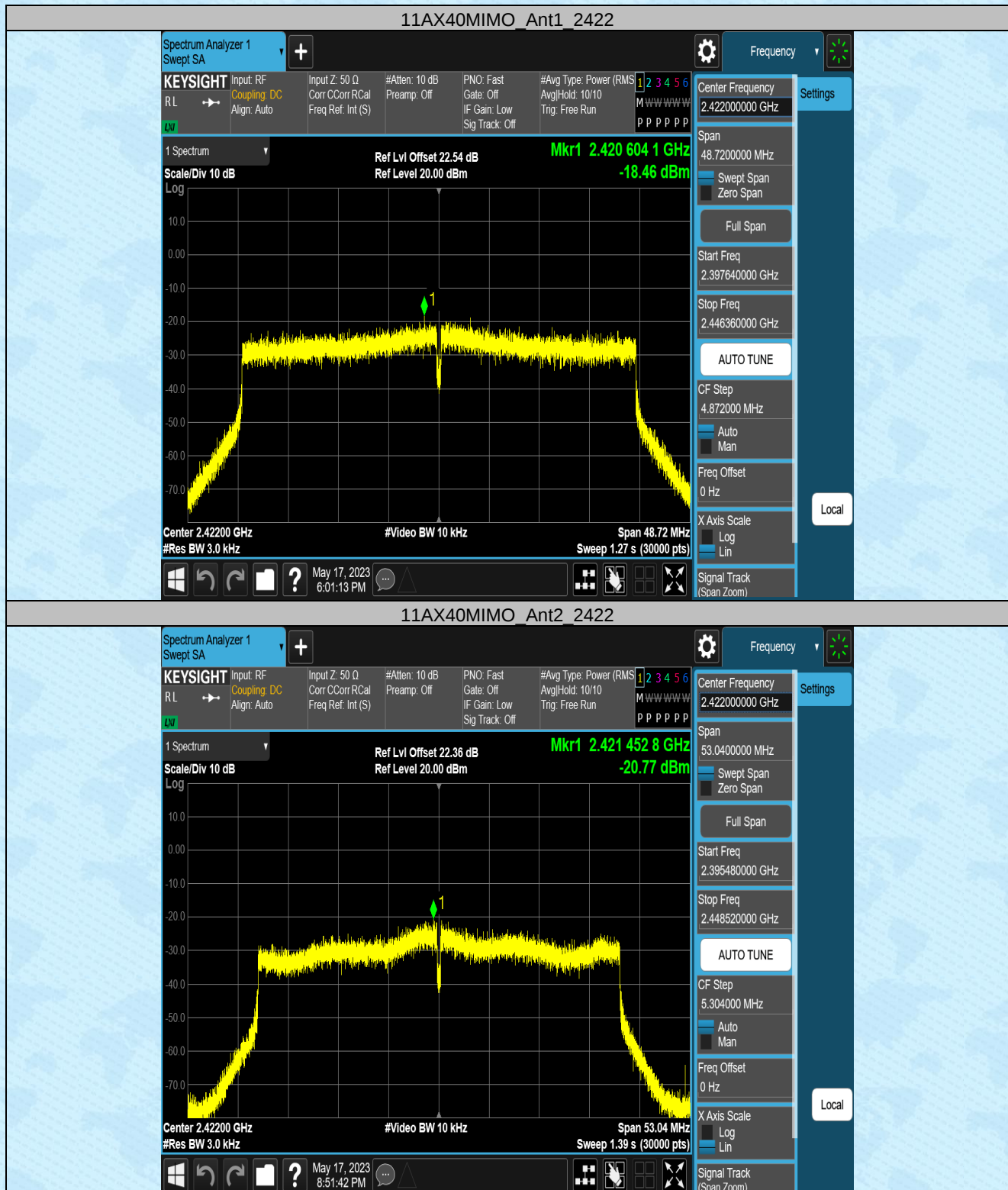


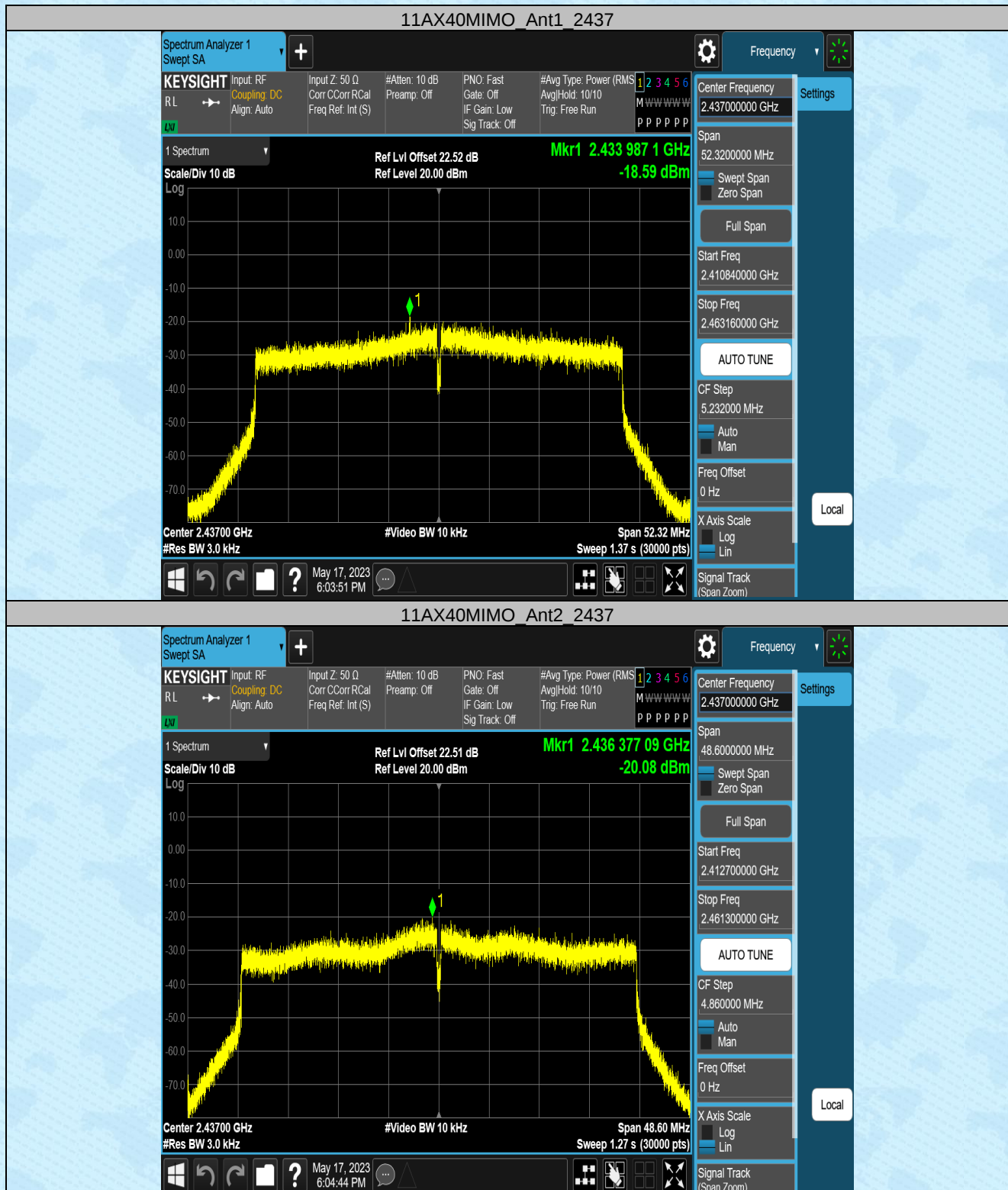


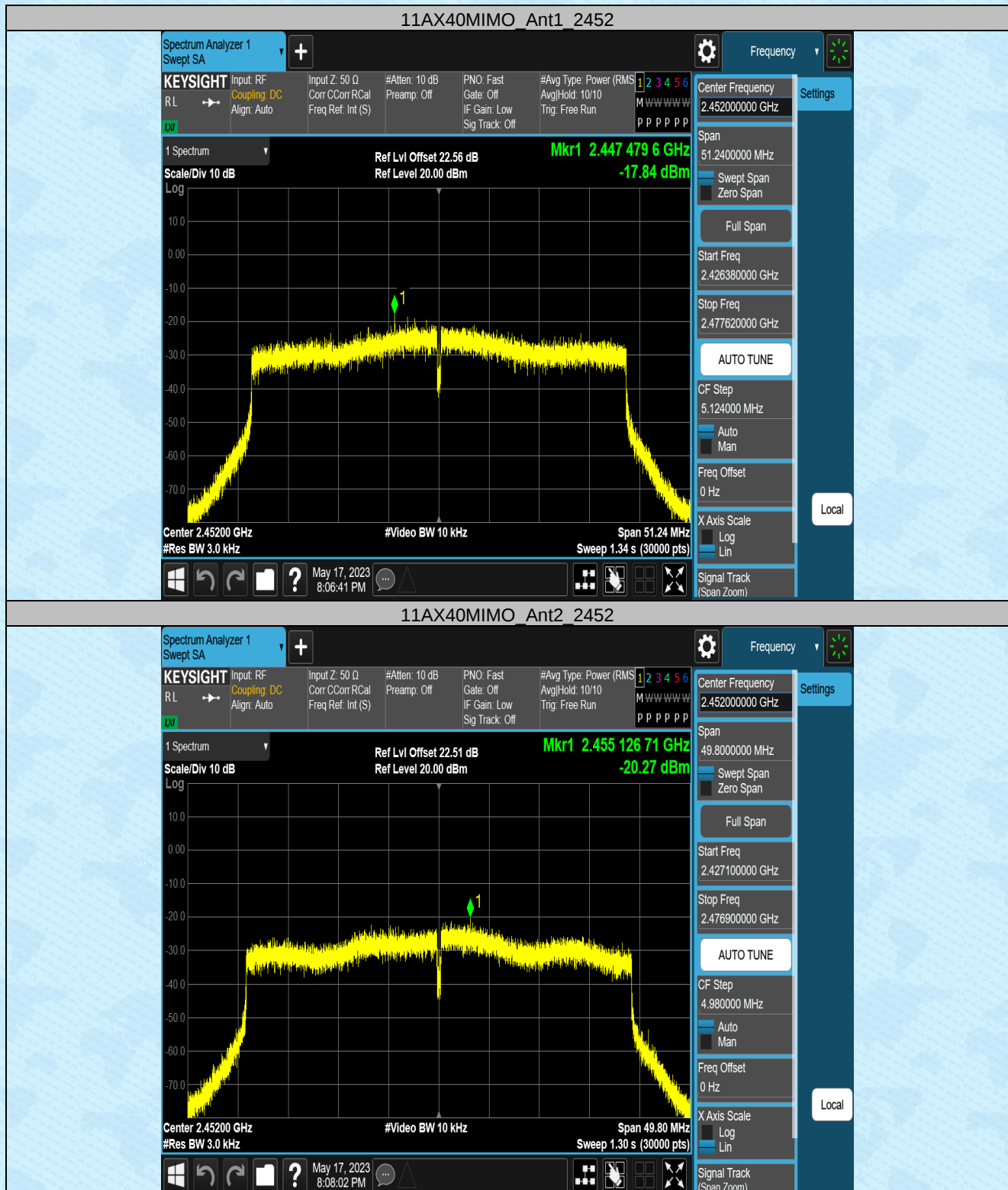






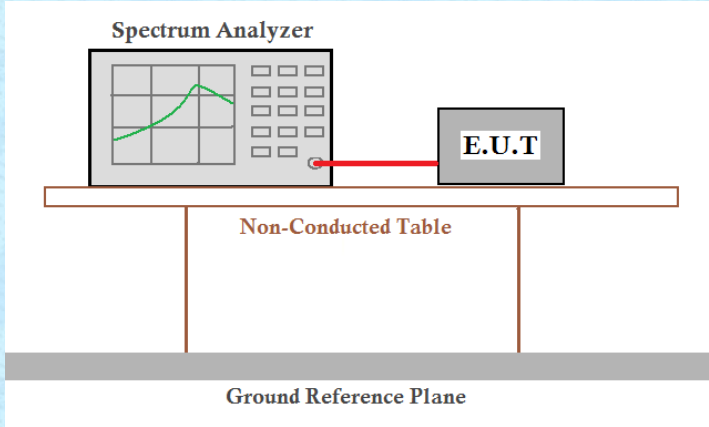






7.6 Spurious Emission in Non-restricted & restricted Bands

7.6.1 Conducted Emission Method

Test Requirement:	FCC Part15 C Section 15.247 (d)
Test Method:	KDB558074 D01 15.247 Meas Guidance v05r02 FCC KDB 662911 D01 Multiple Transmitter Output v02r01
Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 30 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.
Test setup:	 The diagram illustrates the test setup. A Spectrum Analyzer is connected to an E.U.T. (Equipment Under Test) via a red cable. Both the Spectrum Analyzer and the E.U.T. are placed on a Non-Conducted Table. The table is supported by two vertical legs and sits on a Ground Reference Plane.
Test Instruments:	Refer to section 6.0 for details
Test mode:	Refer to section 5.2 for details
Test results:	Pass

Measurement Data:

Conducted Spurious Emission

